

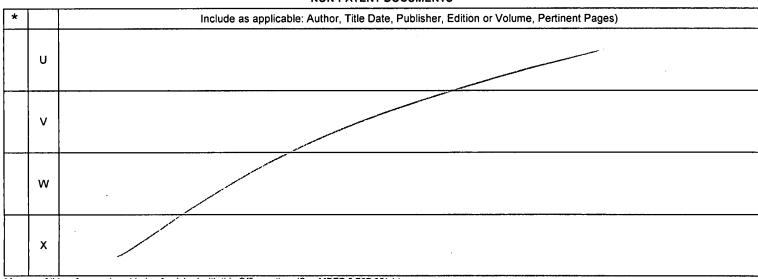
U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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			4			/35/06A&B (07-00)		
Substitute	e for form 1449A&B/	PTO JUN 1 5 200	77 88	Complete If Known				
		4		Application Number	10/702,235			
INFO	PRMATION	NOISCLOS BY APPLIC	MRE	Filing Date	November 5, 2003			
STA	TEMENT E	SY APPLIE	ANT	First Named Inventor	Salmon, Peter C.			
				Art Unit	2813			
	(Use as many she	ets as necessary)		Examiner Name	Harrison, Monica D.			
Sheet	2	of	2	Attorney Docket Number	000939-119030US			

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	Cite	Foreign Patent Document		Publication Date	Name of Patentee or	Pages, Columns, Lines,					
initials*	No.'	Country Code ³ Number ⁴		Kind Code ⁵ (if known)	MM-DD-YYYY	Applicant of Cited Document	Where Relevant Passages or Relevant Figures Appear				
MDH	28	EP	1089331	A2	04-04-2001	PFC Corporation					
l.	29	JP	07169873	Α	07-04-1995	Nippon Electric Co.	Abstract Only	囡			

NON PATENT LITERATURE DOCUMENTS							
Examiner Initials *	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²				
MDG	30	J. Lynn Davis and J. Kevin Arledge, "Thin Film Metallization of Three Dimensional Substrates," 1-4 May 1994, Electronic Components Technology Conference, Proceedings 44th, pp. 359-361					

Examiner Signature	ih	10ne 10, HL	Date Considere	d 7	107	

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